

<b>Notice of References Cited</b>	Application/Control No. 10/536,908	Applicant(s)/Patent Under Reexamination ASOGAWA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,167,790	12-1992	Carle et al.	204/608
	C	US-6,696,022	02-2004	Chan et al.	422/99
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